

Search Notes**Application/Control No.**

09/623,439

Examiner

Y. Lee

Applicant(s)/Patent under Reexamination

BAKER ET AL.

Art Unit

2621

SEARCHED

Class	Subclass	Date	Examiner
348	143 148 157 **	11/9/2005	YL
340	933		
701	301		
H04N	7/18		
update	search	5/25/2006	YL
update	search	10/12/2006	YL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner